


<b>Search Notes</b> 	<b>Application/Control No.</b> 10591334	<b>Applicant(s)/Patent Under Reexamination</b> EILENSTINE, BYRON DUANE
	<b>Examiner</b> YUN QIAN	<b>Art Unit</b> 4162

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN and EAST search (USPat, PGPub, EPO, JPO), 549/215 text search, Consult with Curtis Mayes	8/27/2008	yq

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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